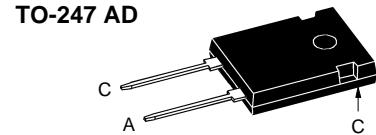
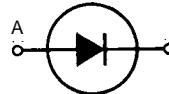


# Fast Recovery Epitaxial Diode (FRED)

## DSEI 120

**I<sub>FAVM</sub> = 109 A**  
**V<sub>RRM</sub> = 1200 V**  
**t<sub>rr</sub> = 40 ns**

V <sub>RSM</sub>	V <sub>RRM</sub>	Type
V	V	
1200	1200	DSEI 120-12A



A = Anode, C = Cathode

Symbol	Test Conditions		Maximum Ratings	
I <sub>FRMS</sub>	T <sub>VJ</sub> = T <sub>VJM</sub>		100	A
I <sub>FAVM</sub> ①	T <sub>C</sub> = 60°C; rectangular, d = 0.5		109	A
I <sub>FAV</sub> ②	T <sub>C</sub> = 95°C; rectangular, d = 0.5		75	A
I <sub>FRM</sub>	t <sub>p</sub> < 10 µs; rep. rating, pulse width limited by T <sub>VJM</sub>		tbd	A
I <sub>FSM</sub>	T <sub>VJ</sub> = 45°C; t = 10 ms (50 Hz), sine		600	A
	t = 8.3 ms (60 Hz), sine		660	A
	T <sub>VJ</sub> = 150°C; t = 10 ms (50 Hz), sine		540	A
	t = 8.3 ms (60 Hz), sine		600	A
I <sup>2</sup> t	T <sub>VJ</sub> = 45°C t = 10 ms (50 Hz), sine		1800	A <sup>2</sup> s
	t = 8.3 ms (60 Hz), sine		1800	A <sup>2</sup> s
	T <sub>VJ</sub> = 150°C; t = 10 ms (50 Hz), sine		1450	A <sup>2</sup> s
	t = 8.3 ms (60 Hz), sine		1500	A <sup>2</sup> s
T <sub>VJ</sub>			-40...+150	°C
T <sub>VJM</sub>			150	°C
T <sub>stg</sub>			-40...+150	°C
P <sub>tot</sub>	T <sub>C</sub> = 25°C		357	W
M <sub>d</sub>	Mounting torque		0.8...1.2	Nm
Weight			6	g

Symbol	Test Conditions		Characteristic Values	
	typ.		max.	
I <sub>R</sub>	T <sub>VJ</sub> = 25°C V <sub>R</sub> = V <sub>RRM</sub>		3	mA
	T <sub>VJ</sub> = 25°C V <sub>R</sub> = 0.8 • V <sub>RRM</sub>		1.5	mA
	T <sub>VJ</sub> = 125°C V <sub>R</sub> = 0.8 • V <sub>RRM</sub>		20	mA
V <sub>F</sub>	I <sub>F</sub> = 70 A; T <sub>VJ</sub> = 150°C		1.55	V
	T <sub>VJ</sub> = 25°C		1.8	V
V <sub>To</sub>	For power-loss calculations only		1.2	V
r <sub>T</sub>	T <sub>VJ</sub> = T <sub>VJM</sub>		4.6	mΩ
R <sub>thJC</sub>			0.35	K/W
R <sub>thCK</sub>			35	K/W
R <sub>thJA</sub>			0.25	K/W
t <sub>rr</sub>	I <sub>F</sub> = 1 A; -di/dt = 200 A/µs; V <sub>R</sub> = 30 V; T <sub>VJ</sub> = 25°C	40	60	ns
I <sub>RM</sub>	V <sub>R</sub> = 350 V; I <sub>F</sub> = 75 A; -di <sub>F</sub> /dt = 200 A/µs	25	30	A
	L ≤ 0.05 µH; T <sub>VJ</sub> = 100°C			

① Chip capability, ② limited to 70 A by leads

Data according to IEC 60747  
 IXYS reserves the right to change limits, test conditions and dimensions

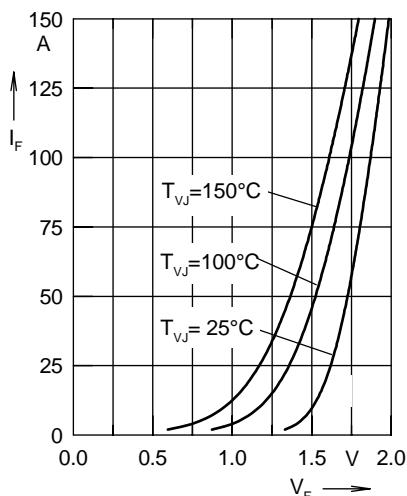


Fig. 1 Forward current  $I_F$  versus  $V_F$

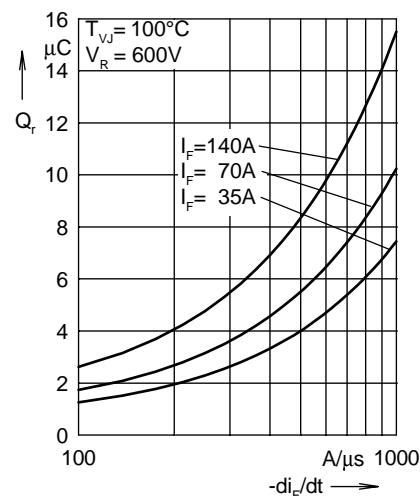


Fig. 2 Reverse recovery charge  $Q_r$  versus  $-di_F/dt$

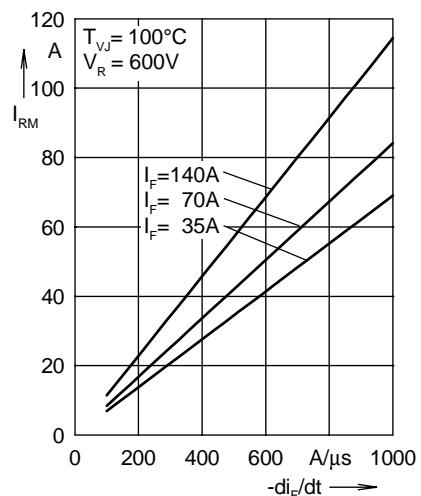


Fig. 3 Peak reverse current  $I_{RM}$  versus  $-di_F/dt$

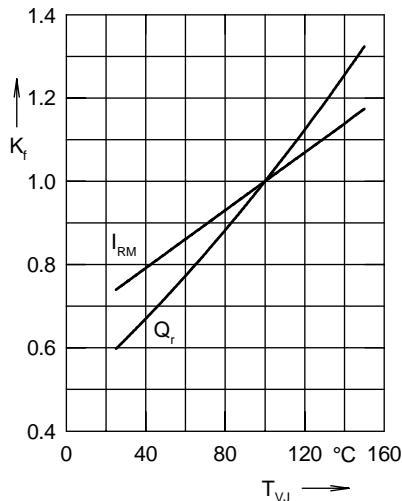


Fig. 4 Dynamic parameters  $Q_r$ ,  $I_{RM}$  versus  $T_{VJ}$

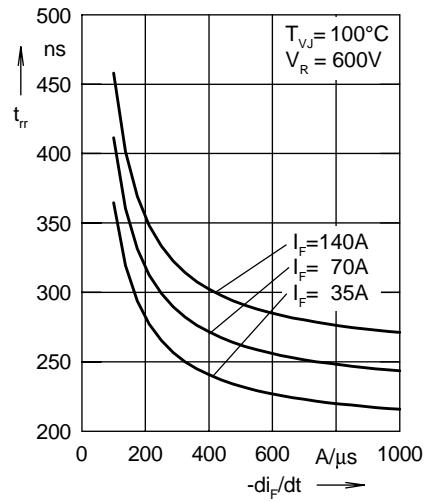


Fig. 5 Recovery time  $t_{rr}$  versus  $-di_F/dt$

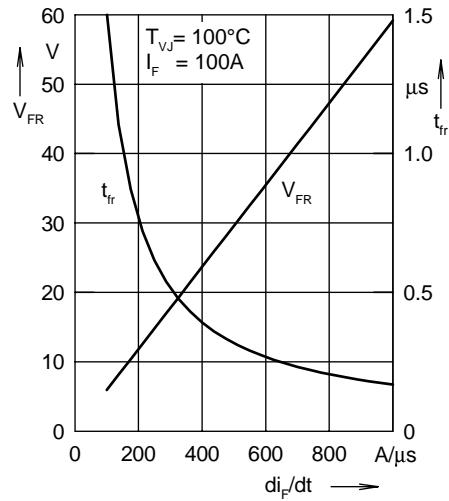


Fig. 6 Peak forward voltage  $V_{FR}$  and  $t_{rr}$  versus  $di_F/dt$

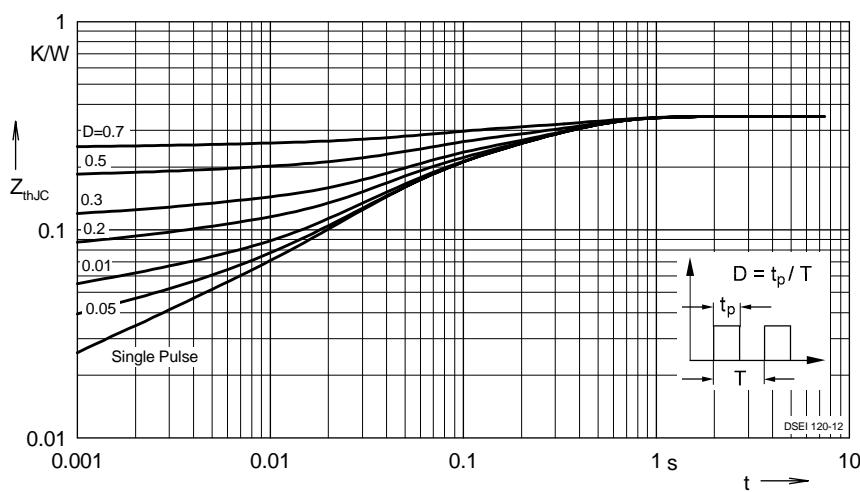


Fig. 7 Transient thermal resistance junction to case

Constants for  $Z_{thJC}$  calculation:

i	$R_{thi}$ (K/W)	$t_i$ (s)
1	0.017	0.00038
2	0.0184	0.0026
3	0.1296	0.0387
4	0.185	0.274